

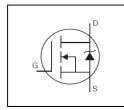
#### **AUTOMOTIVE GRADE**

# AUIRF1010Z AUIRF1010ZS AUIRF1010ZL

HEXEET® POWER MOSEET

#### Features

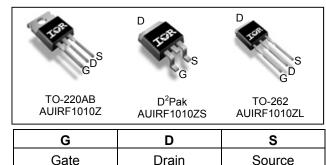
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Timax
- · Lead-Free, RoHS Compliant
- Automotive Qualified \*



|                                  | LEI FOMELMOSEET |
|----------------------------------|-----------------|
| V <sub>DSS</sub>                 | 55V             |
| R <sub>DS(on)</sub> max.         | 7.5mΩ           |
| I <sub>D (Silicon Limited)</sub> | 94A             |
| D (Package Limited)              | 75A             |

### **Description**

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



| Bass nort number | Base part number Package Type |                    | k        | Orderable Part Number |
|------------------|-------------------------------|--------------------|----------|-----------------------|
| base part number |                               |                    | Quantity | Orderable Part Number |
| AUIRF1010Z       | TO-220                        | Tube               | 50       | AUIRF1010Z            |
| AUIRF1010ZL      | TO-262                        | Tube               | 50       | AUIRF1010ZL           |
| AUIRF1010ZS      | D²-Pak                        | Tube               | 50       | AUIRF1010ZS           |
| AUIRF 101025     | D -Pak                        | Tape and Reel Left | 800      | AUIRF1010ZSTRL        |

### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

| Symbol                                  | Parameter   | Max.                    | Units |
|---|---|-------------------------|-------|
| I <sub>D</sub> @ T <sub>C</sub> = 25°C  | Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited) | 94                      |       |
| I <sub>D</sub> @ T <sub>C</sub> = 100°C | Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited) | 66                      | 1     |
| I <sub>D</sub> @ T <sub>C</sub> = 25°C  | Continuous Drain Current, V <sub>GS</sub> @ 10V (Package Limited) | 75                      | A     |
| I <sub>DM</sub>                         | Pulsed Drain Current ①  | 360                     | 1     |
| P <sub>D</sub> @T <sub>C</sub> = 25°C   | Maximum Power Dissipation   | 140                     | W     |
|   | Linear Derating Factor  | 0.90                    | W/°C  |
| $V_{GS}$                                | Gate-to-Source Voltage  | ± 20                    | V     |
| E <sub>AS</sub>                         | Single Pulse Avalanche Energy (Thermally Limited) ②               | 130                     | ma I  |
| E <sub>AS</sub> (tested)                | Single Pulse Avalanche Energy Tested Value ®                      | 180                     | - mJ  |
| I <sub>AR</sub>                         | Avalanche Current ①   | See Fig.15,16, 12a, 12b | Α     |
| E <sub>AR</sub>                         | Repetitive Avalanche Energy ®                                     |                         | mJ    |
| TJ                                      | Operating Junction and  | -55 to + 175            |       |
| $T_{STG}$                               | Storage Temperature Range   |                         | °C    |
|   | Soldering Temperature, for 10 seconds (1.6mm from case)           | 300                     |       |
| _                                       | Mounting torque, 6-32 or M3 screw⑦                                | 10 lbf•in (1.1N•m)      |       |

#### Thermal Resistance

| Symbol           | Parameter  | Тур. | Max. | Units |
|------------------|--|------|------|-------|
| R <sub>θJC</sub> | Junction-to-Case 9                               |      | 1.11 |       |
| $R_{	heta CS}$   | Case-to-Sink, Flat, Greased Surface ⑦            | 0.50 |      | °CAM  |
| $R_{\thetaJA}$   | Junction-to-Ambient ⑦                            |      | 62   | °C/W  |
| $R_{	hetaJA}$    | Junction-to-Ambient ( PCB Mount, steady state) ® |      | 40   |       |

HEXFET® is a registered trademark of Infineon.

<sup>\*</sup>Qualification standards can be found at www.infineon.com



# Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

|                                   | Parameter                            |     | Тур.  | Max. | Units | Conditions  |
|-----------------------------------|--------------------------------------|-----|-------|------|-------|---|
| $V_{(BR)DSS}$                     | Drain-to-Source Breakdown Voltage    | 55  |       |      | V     | $V_{GS} = 0V, I_{D} = 250\mu A$                   |
| $\Delta V_{(BR)DSS}/\Delta T_{J}$ | Breakdown Voltage Temp. Coefficient  |     | 0.049 |      | V/°C  | Reference to 25°C, I <sub>D</sub> = 1mA           |
| R <sub>DS(on)</sub>               | Static Drain-to-Source On-Resistance |     | 5.8   | 7.5  | mΩ    | V <sub>GS</sub> = 10V, I <sub>D</sub> = 75A ③     |
| $V_{GS(th)}$                      | Gate Threshold Voltage               | 2.0 |       | 4.0  | V     | $V_{DS} = V_{GS}$ , $I_D = 250\mu A$              |
| gfs                               | Forward Trans conductance            | 33  |       |      | S     | $V_{DS} = 25V, I_{D} = 75A$                       |
|                                   | Drain to Source Leakage Current      |     |       | 20   |       | $V_{DS} = 55 \text{ V}, V_{GS} = 0 \text{ V}$     |
| IDSS                              | Drain-to-Source Leakage Current      |     |       | 250  | μA    | $V_{DS} = 55V, V_{GS} = 0V, T_{J} = 125^{\circ}C$ |
|                                   | Gate-to-Source Forward Leakage       |     |       | 200  | - Λ   | $V_{GS} = 20V$                                    |
| I <sub>GSS</sub>                  | Gate-to-Source Reverse Leakage       |     |       | -200 | nA    | $V_{GS} = -20V$                                   |

# Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

| -                | •                            | -        |    |    |   |
|------------------|------------------------------|----------|----|----|---|
| $Q_g$            | Total Gate Charge            | <br>63   | 95 |    | I <sub>D</sub> = 75A                                  |
| $Q_{gs}$         | Gate-to-Source Charge        | <br>19   |    | nC | V <sub>DS</sub> = 44V                                 |
| $Q_{gd}$         | Gate-to-Drain Charge         | <br>24   |    |    | V <sub>GS</sub> = 10V③                                |
| $t_{d(on)}$      | Turn-On Delay Time           | <br>18   |    |    | $V_{DD} = 28V$  |
| t <sub>r</sub>   | Rise Time                    | <br>150  |    | no | I <sub>D</sub> = 75A                                  |
| $t_{d(off)}$     | Turn-Off Delay Time          | <br>36   |    | ns | $R_G = 6.8\Omega$                                     |
| t <sub>f</sub>   | Fall Time                    | <br>92   |    |    | V <sub>GS</sub> = 10V ③                               |
| $L_D$            | Internal Drain Inductance    | <br>4.5  |    | nH | Between lead,<br>6mm (0.25in.)                        |
| Ls               | Internal Source Inductance   | <br>7.5  |    | Ш  | from package and center of die contact                |
| C <sub>iss</sub> | Input Capacitance            | <br>2840 |    |    | $V_{GS} = 0V$   |
| Coss             | Output Capacitance           | <br>420  |    |    | V <sub>DS</sub> = 25V                                 |
| C <sub>rss</sub> | Reverse Transfer Capacitance | <br>250  |    | ٦٦ | f = 1.0MHz, See Fig. 5                                |
| Coss             | Output Capacitance           | <br>1630 |    | pF | $V_{GS} = 0V, V_{DS} = 1.0V f = 1.0MHz$               |
| Coss             | Output Capacitance           | <br>360  |    |    | $V_{GS} = 0V$ , $V_{DS} = 44V$ $f = 1.0MHz$           |
| Coss eff.        | Effective Output Capacitance | <br>560  |    |    | $V_{GS}$ = 0V, $V_{DS}$ = 0V to 44V $\textcircled{4}$ |
|                  |                              |          |    |    |   |

#### **Diode Characteristics**

|                 | Parameter                               | Min.      | Тур.   | Max. | Units | Conditions   |  |
|-----------------|---|-----------|--|------|-------|--|--|
| I <sub>S</sub>  | Continuous Source Current (Body Diode)  |           |  | 75   |       | MOSFET symbol showing the                          |  |
| I <sub>SM</sub> | Pulsed Source Current<br>(Body Diode) ① |           |  | 360  | A     | integral reverse p-n junction diode.               |  |
| $V_{SD}$        | Diode Forward Voltage                   |           |  | 1.3  | V     | $T_J = 25^{\circ}C, I_S = 75A, V_{GS} = 0V $ ③     |  |
| t <sub>rr</sub> | Reverse Recovery Time                   |           | 22   | 33   | ns    | $T_J = 25^{\circ}C$ , $I_F = 75A$ , $V_{DD} = 25V$ |  |
| $Q_{rr}$        | Reverse Recovery Charge                 |           | 15   | 23   | nC    | di/dt = 100A/µs ③                                  |  |
| t <sub>on</sub> | Forward Turn-On Time                    | Intrinsio | Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> ) |      |       |  |  |

#### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Limited by  $T_{Jmax_i}$  starting  $T_J = 25$ °C, L = 0.05mH,  $R_G = 25\Omega$ ,  $I_{AS} = 75$ A,  $V_{GS} = 10$ V. Part not recommended for use above this value.
- $\oplus$  C<sub>oss</sub> eff. is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- © Limited by T<sub>Jmax</sub>, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- $\odot$  This value determined from sample failure population, starting T<sub>J</sub> = 25°C, L = 0.05mH, R<sub>G</sub> = 25 $\Omega$ , I<sub>AS</sub> = 75A, V<sub>GS</sub> =10V.
- This is only applied to TO-220AB package.
- ® When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994



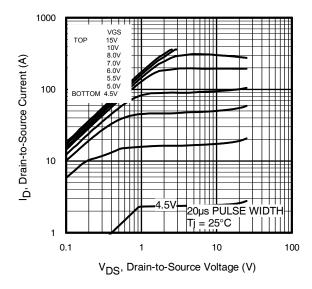


Fig. 1 Typical Output Characteristics

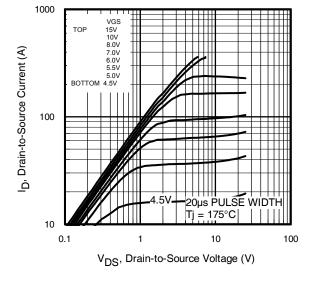


Fig. 2 Typical Output Characteristics

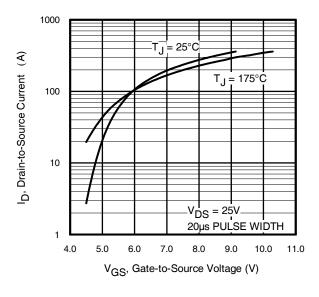
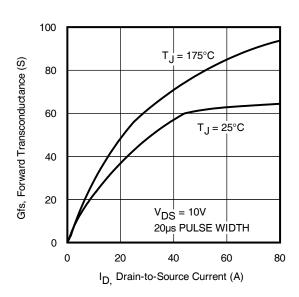
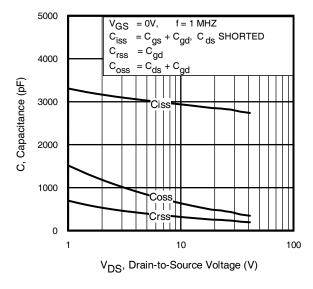


Fig. 3 Typical Transfer Characteristics

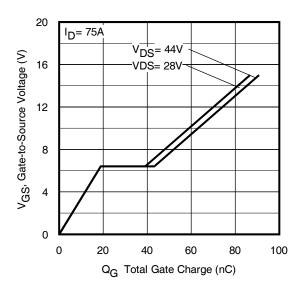


**Fig. 4** Typical Forward Trans conductance vs. Drain Current





**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage



**Fig 6.** Typical Gate Charge vs. Gate-to-Source Voltage

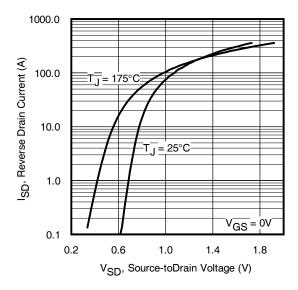


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

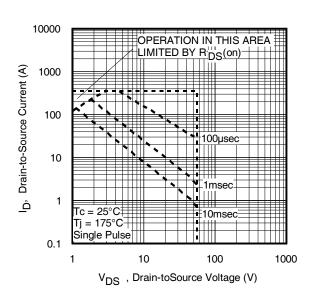
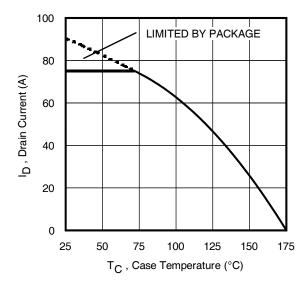


Fig 8. Maximum Safe Operating Area

4





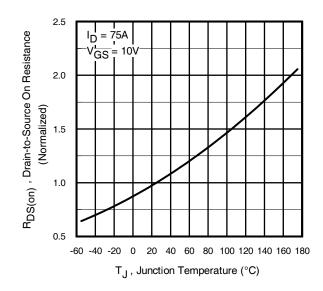


Fig 9. Maximum Drain Current vs. Case Temperature

**Fig 10.** Normalized On-Resistance vs. Temperature

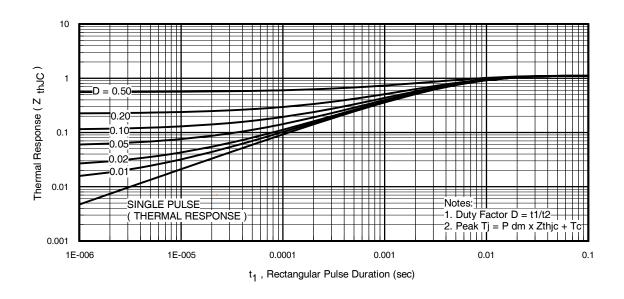


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



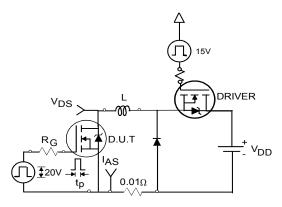


Fig 12a. Unclamped Inductive Test Circuit

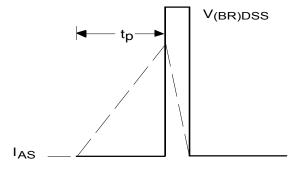


Fig 12b. Unclamped Inductive Waveforms

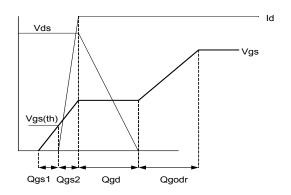


Fig 13a. Gate Charge Waveform

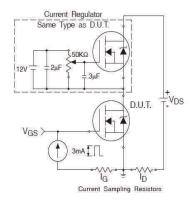
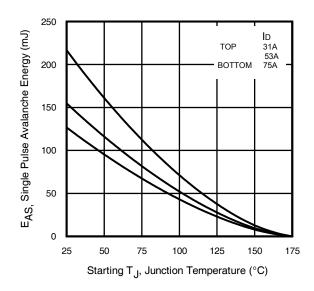


Fig 13b. Gate Charge Test Circuit



**Fig 12c.** Maximum Avalanche Energy vs. Drain Current

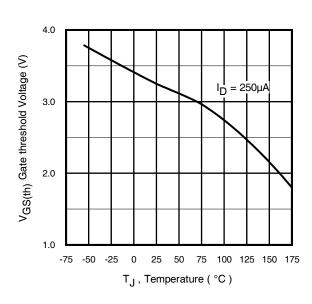


Fig 14. Threshold Voltage vs. Temperature



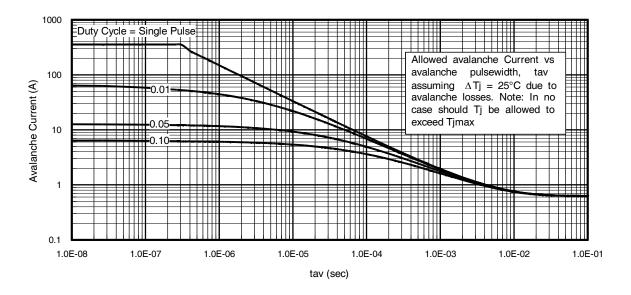
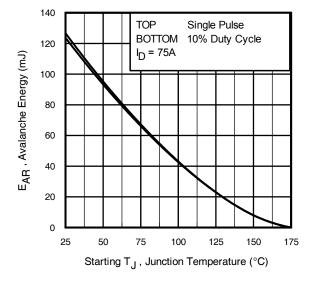


Fig 15. Typical Avalanche Current vs. Pulse width



**Fig 16.** Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 15, 16: (For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption:

  Durally a thermal phanemana and failure.
  - Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as T<sub>jmax</sub> is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. lav = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 15, 16).

tav = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T / \; Z_{thJC} \\ I_{av} &= 2\Delta T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$



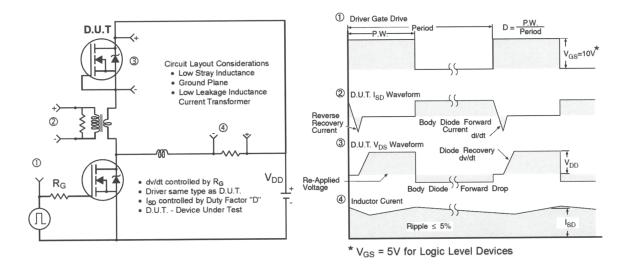


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

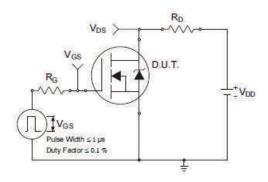


Fig 18a. Switching Time Test Circuit

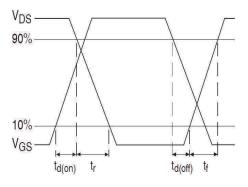
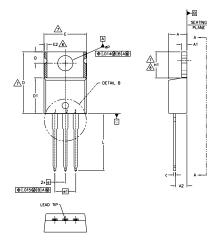
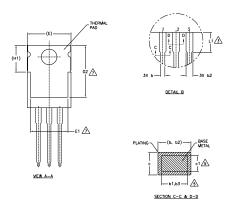


Fig 18b. Switching Time Waveforms



# TO-220AB Package Outline (Dimensions are shown in millimeters (inches))





#### NOTES:

- DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994.

- DIMENSIONING AND TOLERANGING AS PER ASME 114.5 M = 1994.

  DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS].

  LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.

  DIMENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH

  SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

DIMENSION 61, 63 & c1 APPLY TO BASE METAL ONLY.

- CONTROLLING DIMENSION: INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1
- DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED.
- OUTLINE CONFORMS TO JEDEC TO-220, EXCEPT A2 (max.) AND D2 (min.) WHERE DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE.

| SYMBOL | MILLIM | ETERS | INC  |      |       |
|--------|--------|-------|------|------|-------|
|        | MIN.   | MAX.  | MIN. | MAX. | NOTES |
| A      | 3.56   | 4.83  | .140 | .190 |       |
| A1     | 1.14   | 1.40  | .045 | .055 |       |
| A2     | 2.03   | 2.92  | .080 | .115 |       |
| Ь      | 0.38   | 1.01  | .015 | .040 |       |
| b1     | 0.38   | 0.97  | .015 | .038 | 5     |
| b2     | 1,14   | 1.78  | .045 | .070 |       |
| b3     | 1.14   | 1.73  | .045 | .068 | 5     |
| c      | 0.36   | 0.61  | .014 | .024 |       |
| c1     | 0.36   | 0.56  | .014 | .022 | 5     |
| D      | 14.22  | 16.51 | .560 | .650 | 4     |
| D1     | 8.38   | 9.02  | .330 | .355 |       |
| D2     | 11.68  | 12.88 | .460 | .507 | 7     |
| E      | 9.65   | 10.67 | .380 | .420 | 4,7   |
| E1     | 6.86   | 8.89  | .270 | .350 | 7     |
| E2     | -      | 0.76  | _    | .030 | 8     |
| e      | 2.54   | BSC   | .100 | BSC  |       |
| e1     | 5.08   | BSC   | .200 | BSC  |       |
| H1     | 5.84   | 6.86  | .230 | .270 | 7,8   |
| L      | 12.70  | 14.73 | .500 | .580 |       |
| L1     | 3.56   | 4.06  | .140 | .160 | 3     |
| ØΡ     | 3.54   | 4.08  | .139 | .161 |       |
| Q      | 2.54   | 3.42  | .100 | .135 |       |

#### LEAD ASSIGNMENTS

#### HEXFET

- 1.- GATE 2.- DRAIN 3.- SOURCE

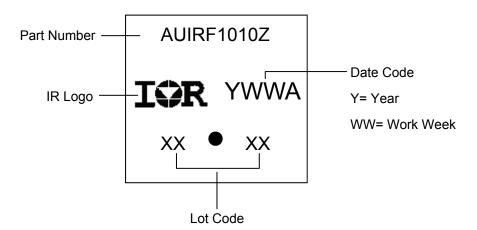
#### IGBTs, CoPACK

1.- GATE 2.- COLLECTOR 3.- EMITTER

#### DIODES

- 1.- ANODE 2.- CATHODE 3.- ANODE

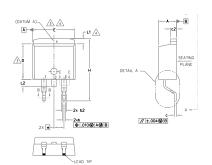
# **TO-220AB Part Marking Information**

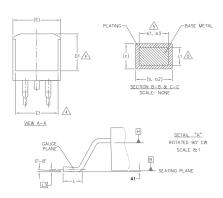


TO-220AB package is not recommended for Surface Mount Application.



# D<sup>2</sup>Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

| S      |        | N     |      |        |                  |  |
|--------|--------|-------|------|--------|------------------|--|
| M<br>B | MILLIM | ETERS | INC  | INCHES |                  |  |
| 0<br>L | MIN.   | MAX.  | MIN. | MAX.   | O<br>T<br>E<br>S |  |
| А      | 4.06   | 4.83  | .160 | .190   |                  |  |
| A1     | 0.00   | 0.254 | .000 | .010   |                  |  |
| Ь      | 0.51   | 0.99  | .020 | .039   |                  |  |
| ь1     | 0.51   | 0.89  | .020 | .035   | 5                |  |
| b2     | 1.14   | 1.78  | .045 | .070   |                  |  |
| ь3     | 1.14   | 1.73  | .045 | .068   | 5                |  |
| С      | 0.38   | 0.74  | .015 | .029   |                  |  |
| c1     | 0.38   | 0.58  | .015 | .023   | 5                |  |
| c2     | 1.14   | 1.65  | .045 | .065   |                  |  |
| D      | 8.38   | 9.65  | .330 | .380   | 3                |  |
| D1     | 6.86   | _     | .270 | _      | 4                |  |
| E      | 9.65   | 10.67 | .380 | .420   | 3,4              |  |
| E1     | 6.22   | _     | .245 | _      | 4                |  |
| е      | 2.54   | BSC   | .100 | BSC    |                  |  |
| Н      | 14.61  | 15.88 | .575 | .625   |                  |  |
| L      | 1.78   | 2.79  | .070 | .110   |                  |  |
| L1     | _      | 1.68  | _    | .066   | 4                |  |
| L2     | _      | 1.78  | _    | .070   |                  |  |
| L3     | 0.25   | BSC   | .010 | BSC    |                  |  |

#### LEAD ASSIGNMENTS

#### DIODES

1.- ANODE (TWO DIE) / OPEN (ONE DIE)
2, 4.- CATHODE
3.- ANODE

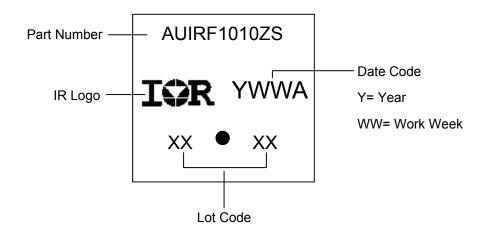
### HEXFET

IGBTs, CoPACK

1.- GATE 2, 4.- DRAIN 3.- SOURCE

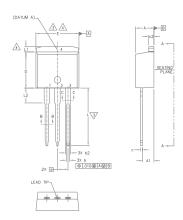
2, 4.- COLLECTOR 3.- EMITTER

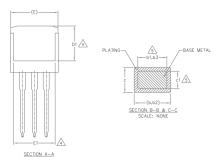
# D<sup>2</sup>Pak (TO-263AB) Part Marking Information





# TO-262 Package Outline (Dimensions are shown in millimeters (inches)





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

3\DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.

6. CONTROLLING DIMENSION: INCH.

7.- OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

#### LEAD ASSIGNMENTS

#### IGBTs, CoPACK

- 1.- GATE 2.- COLLECTOR 3.- EMITTER 4.- COLLECTOR

#### HEXFET

DIODES

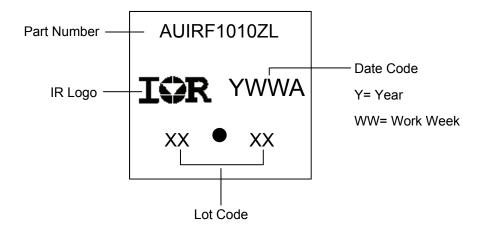
1.- ANODE (TWO DIE) / OPEN (ONE DIE)
2, 4.- CATHODE
3.- ANODE 1.- GATE

DRAIN

| 5. — | SOURCE | ٥. – | AN |
|------|--------|------|----|
| 4.—  | DRAIN  |      |    |
|      |        |      |    |

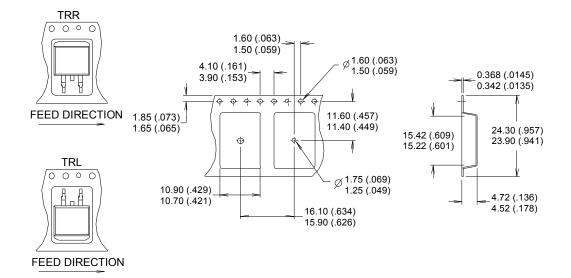
| S  |        |       |        |      |           |
|----|--------|-------|--------|------|-----------|
| M  |        | DIMEN | ISIONS |      | N         |
| B  | MILLIM | ETERS | INC    | HES  | N O T E S |
| L  | MIN.   | MAX.  | MIN.   | MAX. | S         |
| Α  | 4.06   | 4.83  | .160   | .190 |           |
| A1 | 2.03   | 3.02  | .080   | .119 |           |
| b  | 0.51   | 0.99  | .020   | .039 |           |
| ь1 | 0.51   | 0.89  | .020   | .035 | 5         |
| b2 | 1.14   | 1.78  | .045   | .070 |           |
| ь3 | 1.14   | 1.73  | .045   | .068 | 5         |
| С  | 0.38   | 0.74  | .015   | .029 |           |
| с1 | 0.38   | 0.58  | .015   | .023 | 5         |
| c2 | 1.14   | 1.65  | .045   | .065 |           |
| D  | 8.38   | 9.65  | .330   | .380 | 3         |
| D1 | 6.86   | -     | .270   | _    | 4         |
| Ε  | 9.65   | 10.67 | .380   | .420 | 3,4       |
| E1 | 6.22   | _     | .245   |      | 4         |
| е  | 2.54   | BSC   | .100   | BSC  |           |
| L  | 13.46  | 14.10 | .530   | .555 |           |
| L1 | _      | 1.65  | _      | .065 | 4         |
| L2 | 3.56   | 3.71  | .140   | .146 |           |

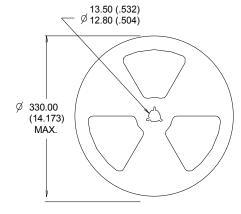
# **TO-262 Part Marking Information**





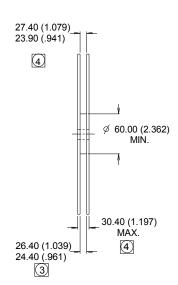
# D<sup>2</sup>Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))







- COMFORMS TO EIA-418.
- CONTROLLING DIMENSION: MILLIMETER.
- 3
- DIMENSION MEASURED @ HUB.
  INCLUDES FLANGE DISTORTION @ OUTER EDGE.





#### **Qualification Information**

| Qualification Level        |   | Automotive (per AEC-Q101)   |  |  |  |
|----------------------------|---|---|--|--|--|
|                            |   | Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level. |  |  |  |
| Moisture Sensitivity Level |   | N/A   |  |  |  |
|                            |   | MSL1  |  |  |  |
|                            |   | IVISL I   |  |  |  |
| Machine Madel              | Class M4 (+/- 700V) <sup>†</sup>                    |   |  |  |  |
| wacrime woder              | AEC-Q101-002  |   |  |  |  |
| Liveran Dady Madal         | Class H1C (+/-1500V) <sup>†</sup>                   |   |  |  |  |
| Human Body Model           | AEC-Q101-001  |   |  |  |  |
| Observed Basis Adada       | Class C5 (+/-2000V) <sup>†</sup>                    |   |  |  |  |
| Charged Device Model       | AEC-Q101-005  |   |  |  |  |
| RoHS Compliant             |   | Yes   |  |  |  |
|                            | Machine Model Human Body Model Charged Device Model | Industrial and Control Automotive level  TO-220AB  TO-262  D²-Pak  Machine Model  Human Body Model  Charged Device Model  |  |  |  |

<sup>†</sup> Highest passing voltage.

### **Revision History**

| Date       | Comments   |
|------------|--|
| 11/6//2015 | <ul> <li>Updated datasheet with corporate template</li> <li>Corrected ordering table on page 1.</li> </ul> |
| 9/18/2017  | Corrected typo error on part marking on page 9,10,11.  |

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